


<b>Search Notes</b>  	<b>Application/Control No.</b>  10597037	<b>Applicant(s)/Patent Under Reexamination</b>  MEIER ET AL.
	<b>Examiner</b>  MARINA TIETJEN	<b>Art Unit</b>  3753

SEARCHED			
Class	Subclass	Date	Examiner
251	149-149.9, 89.5, 142	11/3/2008	MT
137	615, 616.7, 616.7, 377, 382	11/3/2008	MT
285	45	11/4/2008	MT
222	519	11/5/2008	MT

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (see attached History)	11/3/2008	MT
PLUS Search	11/3/2008	MT
Inventor Name Search	11/3/2008	MT
Consulted John Rivell concerning class searches	11/4/2008	MT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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